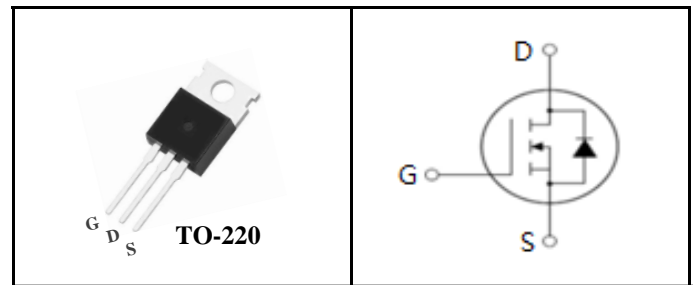


Features

- $BV_{DSS}=100V$, $I_D=87A$
- $R_{DS(on)}:6.5m\Omega$ (Max) @ $V_{GS}=10V$
- $R_{DS(on)}:9.0m\Omega$ (Max) @ $V_{GS}=4.5V$
- N-Channel, 5V Logic Level Control
- Enhancement mode
- Very low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5V$
- 100% Avalanche test



Device Marking and Package Information

Ordering code	Package	Marking
MPGP10R065	TO-220	MPGP10R065

Maximum ratings, at $T_A=25^\circ C$, unless otherwise specified

Symbol	Parameter	Rating	Unit	
$V_{(BR)DSS}$	Drain-Source breakdown voltage	100	V	
V_{GS}	Gate-Source voltage	± 20	V	
I_S	Diode continuous forward current	$T_C=25^\circ C$	87	A
I_D	Continuous drain current @ $V_{GS}=10V$	$T_C=25^\circ C$	87	A
		$T_C=100^\circ C$	62	A
I_{DM}	Pulse drain current tested ①	$T_C=25^\circ C$	376	A
I_{DSM}	Continuous drain current @ $V_{GS}=10V$	$T_A=25^\circ C$	10	A
		$T_A=70^\circ C$	8	A
EAS	Avalanche energy, single pulsed ②	41	mJ	
P_D	Maximum power dissipation	$T_C=25^\circ C$	100	W
P_{DSM}	Maximum power dissipation ③	$T_A=25^\circ C$	1.25	W
T_{STG}, T_J	Storage and Junction Temperature Range	-55 to 175	$^\circ C$	

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.5	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	$^\circ C/W$



Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_j=25°C (unless otherwise stated)						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	100	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T _j =125°C)	V _{DS} =100V, V _{GS} =0V	--	--	100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.1	--	2.5	V
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =10V, I _D =20A	--	5.5	6.5	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =4.5V, I _D =15A	--	7.0	9.0	mΩ
Dynamic Electrical Characteristics @ T_j = 25°C (unless otherwise stated)						
C _{iss}	Input Capacitance	V _{DS} =50V, V _{GS} =0V, f=1MHz	--	3129	--	pF
C _{oss}	Output Capacitance		--	774	--	pF
C _{rss}	Reverse Transfer Capacitance		--	85	--	pF
R _g	Gate Resistance	f=1MHz	--	1	--	Ω
Q _g	Total Gate Charge	V _{DS} =50V, I _D =20A, V _{GS} =10V	--	46	--	nC
Q _{gs}	Gate-Source Charge		--	6.5	--	nC
Q _{gd}	Gate-Drain Charge		--	9	--	nC
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{DD} =50V, I _D =20A, R _G =3Ω, V _{GS} =10V	--	11.7	--	ns
t _r	Turn-on Rise Time		--	7.2	--	ns
t _{d(off)}	Turn-Off Delay Time		--	34.5	--	ns
t _f	Turn-Off Fall Time		--	12.3	--	ns
Source- Drain Diode Characteristics @ T_j = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =20A, V _{GS} =0V	--	0.8	1.2	V
t _{rr}	Reverse Recovery Time	T _j =25°C, I _{sd} =20A, V _{GS} =0V di/dt=500A/μs	--	21.6	--	ns
Q _{rr}	Reverse Recovery Charge		--	44.7	--	nC

NOTE:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Limited by T_{Jmax}, starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = 10A, V_{GS} = 10V. Part not recommended for use above this value
- ③ The power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C.
- ④ Pulse width ≤ 300μs; duty cycles ≤ 2%.

Typical Characteristics

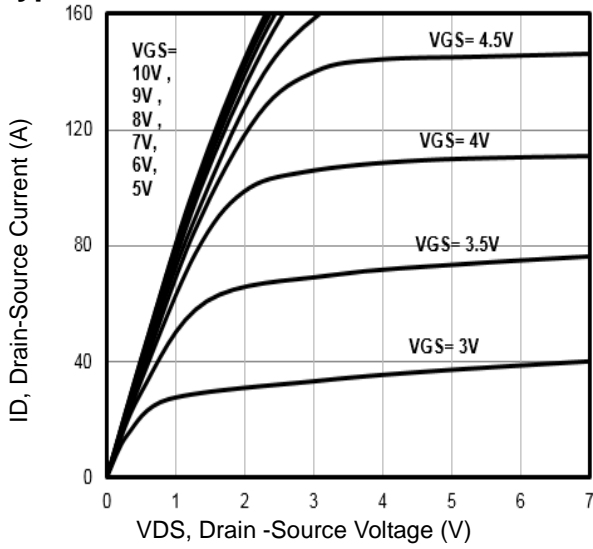


Fig1. Typical Output Characteristics

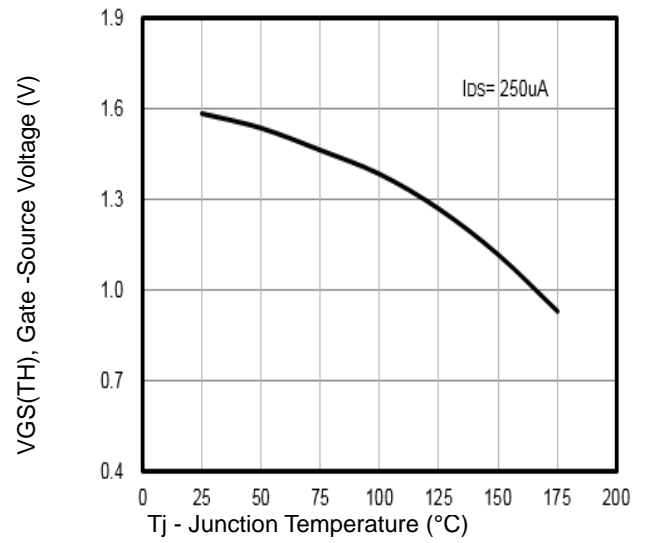


Fig2. $V_{GS(TH)}$ Gate-Source Voltage Vs. T_j

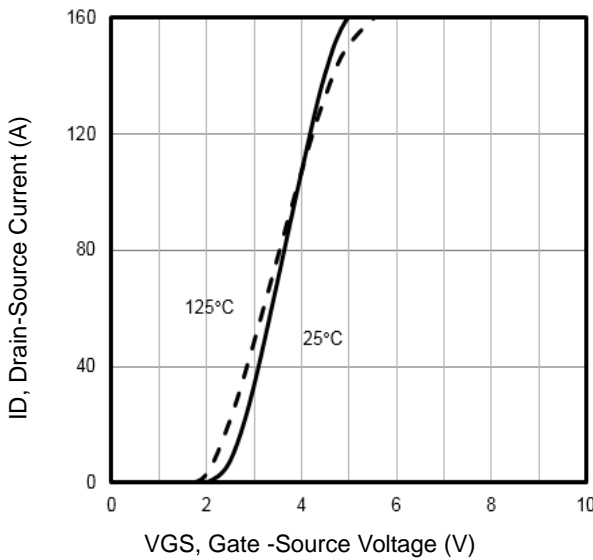


Fig3. Typical Transfer Characteristics

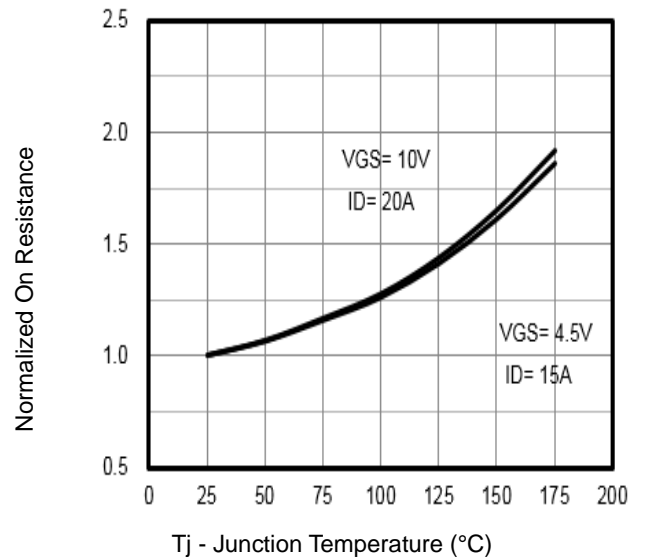


Fig4. Normalized On-Resistance Vs. T_j

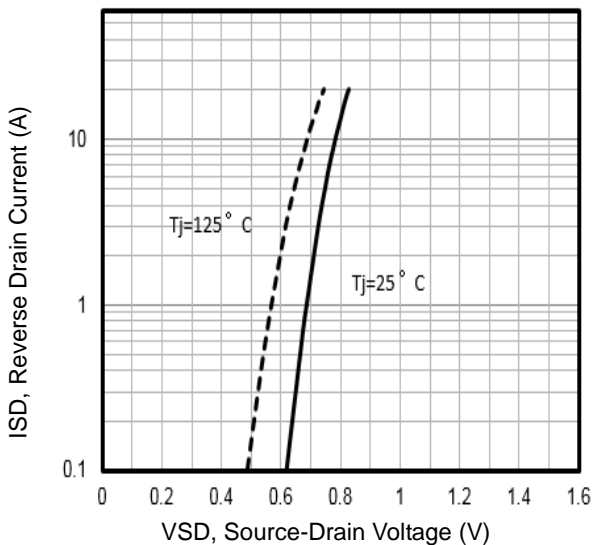


Fig5. Typical Source-Drain Diode Forward Voltage

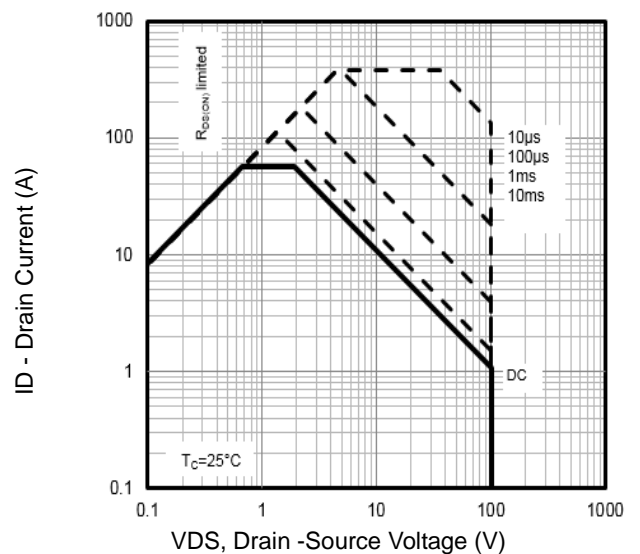


Fig6. Maximum Safe Operating Area

Typical Characteristics

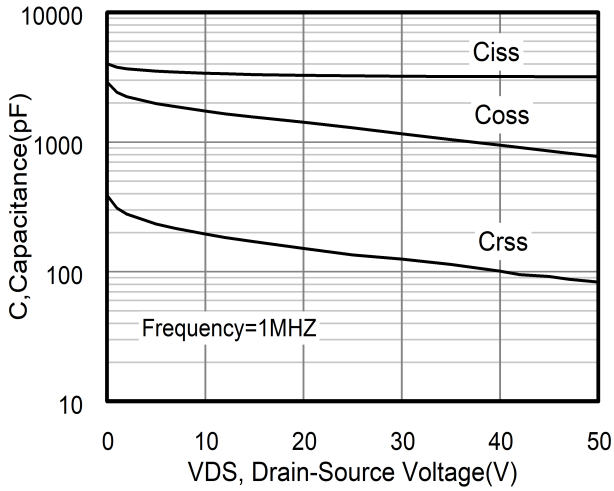


Fig7. Typical Capacitance Vs. Drain-Source Voltage

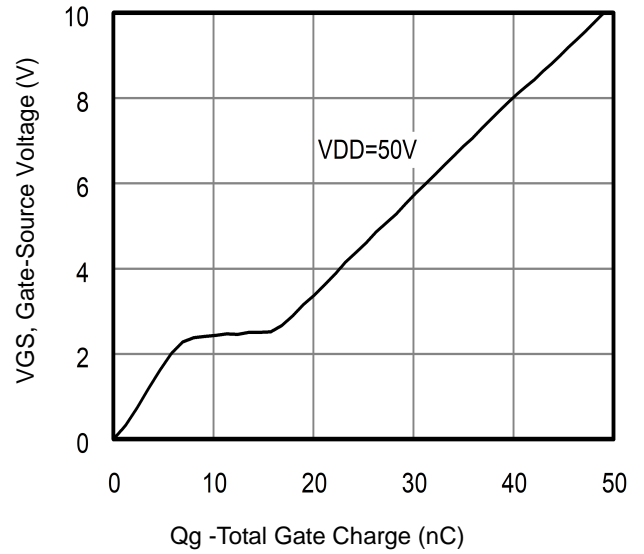


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

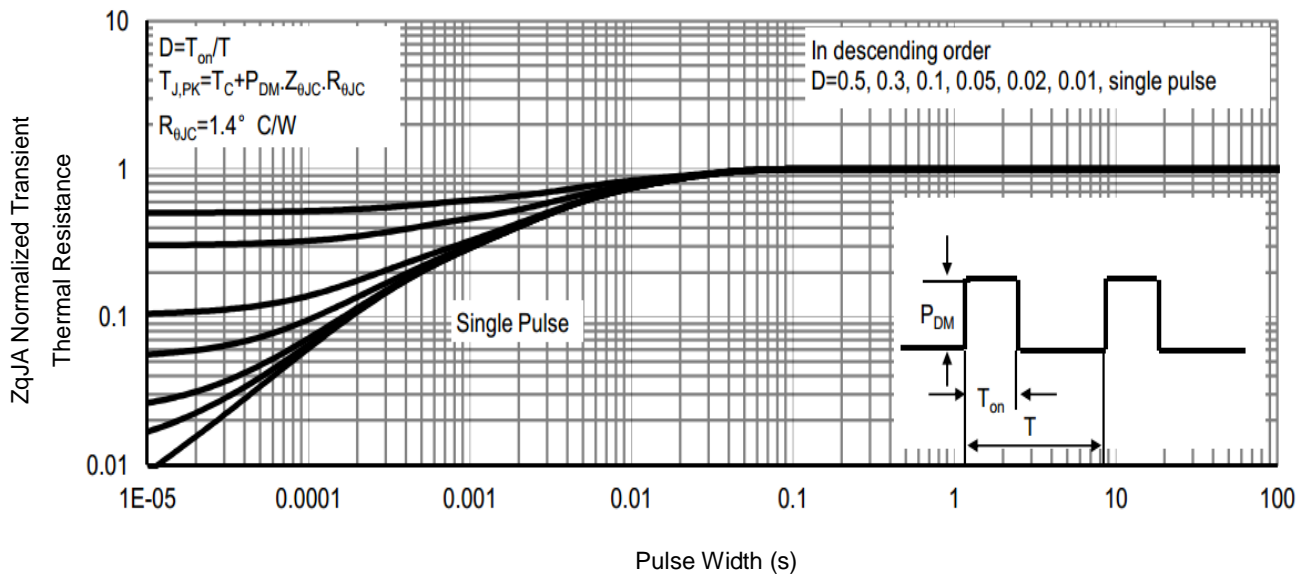


Fig9. Normalized Maximum Transient Thermal Impedance

Figure A: Gate Charge Test Circuit and Waveform

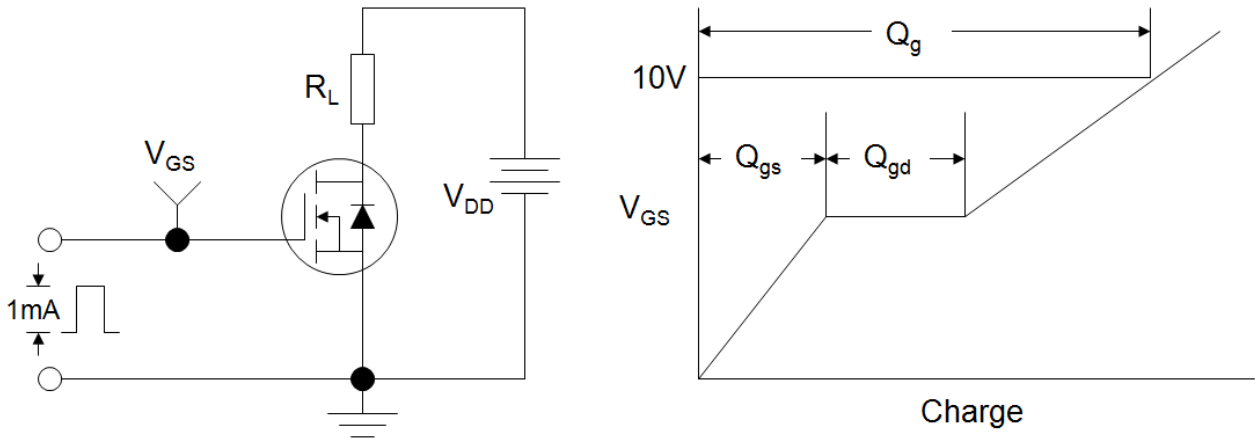


Figure B: Resistive Switching Test Circuit and Waveform

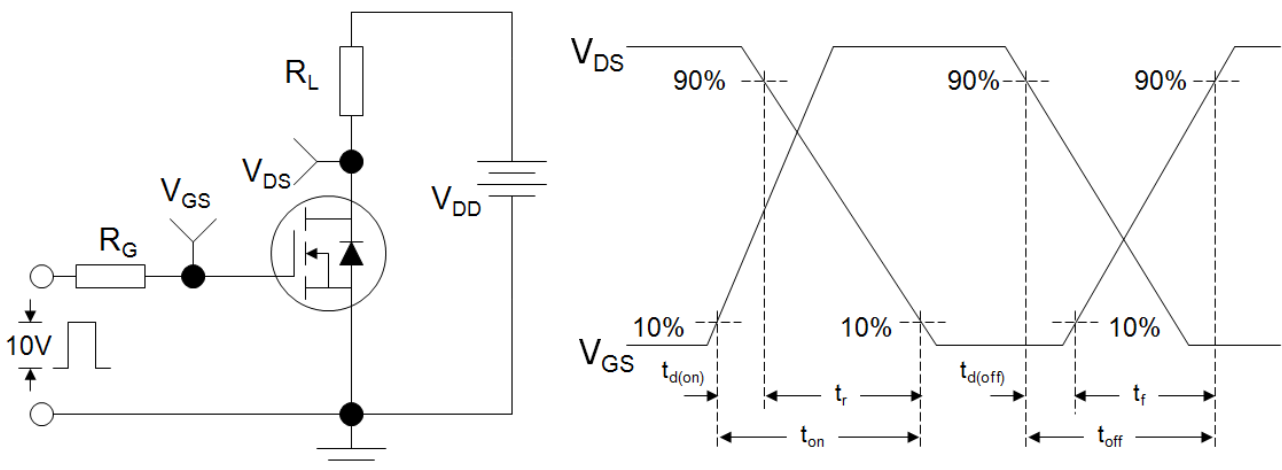
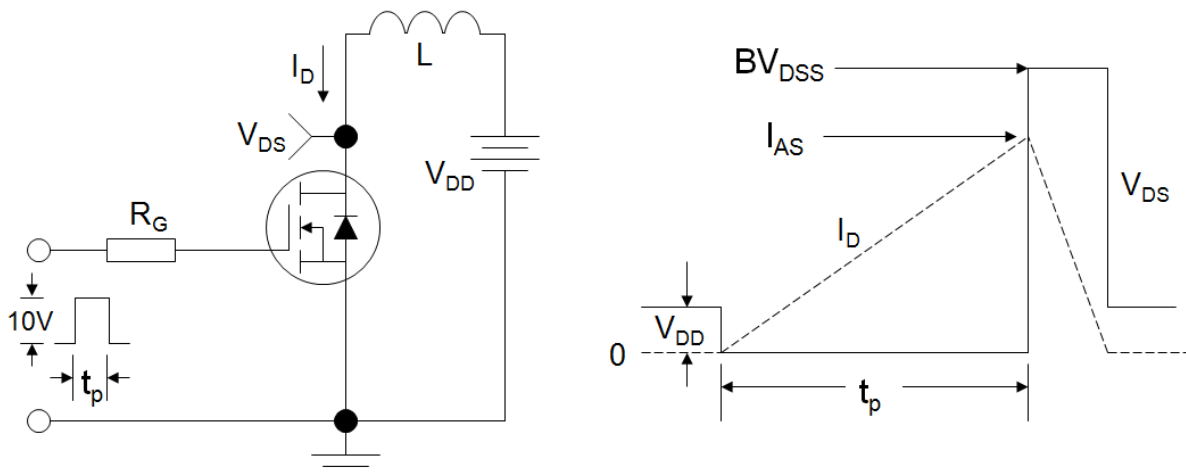
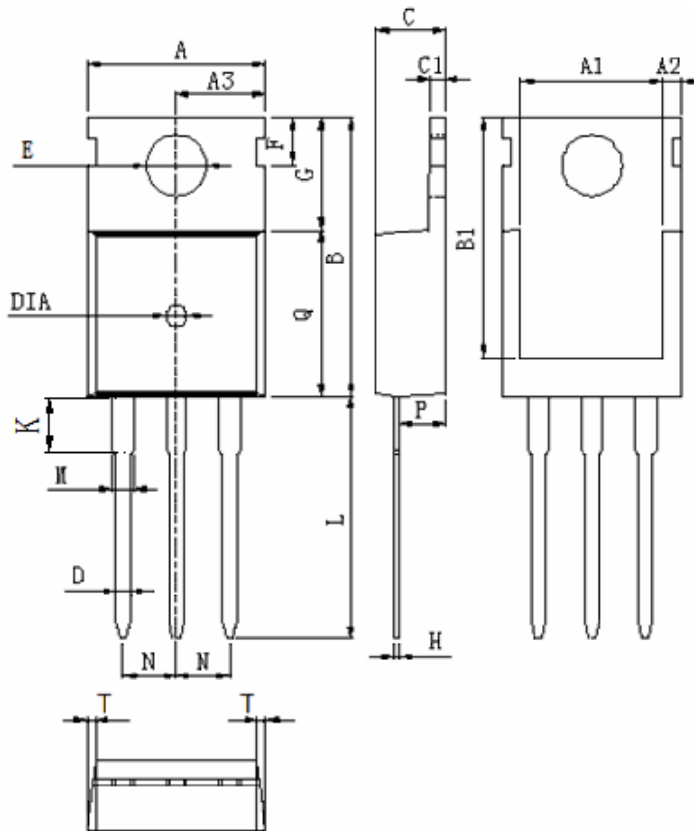


Figure C: Unclamped Inductive Switching Test Circuit and Waveform



TO-220



DIM	MILLIMETERS
A	10.0±0.3
A1	8.64±0.2
A2	1.15±0.1
A3	5.0±0.2
B	15.8±0.4
B1	13.2±0.3
C	4.56±0.1
C1	1.3±0.2
D	0.8±0.2
E	3.6±0.2
F	2.95±0.3
G	6.5±0.3
H	0.5±0.1
K	3.1±0.2
L	13.2±0.4
M	1.25±0.1
N	2.54±0.1
P	2.4±0.3
Q	9.0±0.3
T	W:0.35
DIA	⊙1.5 (deep 0.2)

Unit :mm